150-to-400V, 150W Boost

EXPERIMENTAL EXAMPLE



ZVS with Si diode



- ZVS turn-ON
 - Eliminated losses due to C_{sw} discharge during turn-ON transient
 - Eliminated losses due to MOSFET di_F/dt during turn-ON transient
- Diode reverse recovery still impacts the waveforms and losses
- Increased current ripple
 - Increased conduction losses (by >30%)
 - Increased dv_{ds}/dt upon turn-OFF, MOSFET turn-OFF speed is more important

D. Costinett, D. Maksimovic, R. Zane, A. Rodríguez and A. Vázquez, "Comparison of reverse recovery behavior of silicon and wide bandgap diodes in high frequency power converters"



Loss Breakdown: Soft-Switched Si Boost



Soft-switched SiC diode

 $v_{ds}(t)$

2.00 A

2) 200 V

200ns

2.44621ms 2.44621ms

Max

2.39 A

 $f_{\rm s}$ = 1 MHz



1.00001MHz

12:33:52

4.52 A

• $t_{rr} = 0, Q_{rr} = 0$ • $2C_{d,Qeq} - C_{d,eq} = 64 \text{ pF}$

•
$$V_D = 1.8 \text{ V}$$



Soft-switched Boost with SiC diode



Power supply technology limits become dominated by:

- Magnetics
- 2nd-order switching loss mechanisms, e.g. gate-drive losses, parasitic inductances (layout and packaging)
- Gate-drive circuitry and controllers to support high-frequency operation



Speed Limitations WBG Devices



TriQuint TGF2023-02 12W, DC-to-18 GHz RF/microwave HEMT

FOM for switching applications $C_{ds}R_{on} \approx 1 \ \Omega \text{pF}$ $Q_a R_{on} \approx 10 \ \Omega \text{pC}$ Standard hard-switched PWM operation at 50 MHz dv_{ds}/dt dominated by probe (4 pF) capacitance



Emerging GaN HEMT devices may enable completely new RF-based design approaches in power electronics



VHF power electronics [11]



[11] D.J. Perreault, et..al. "Opportunities and challenges in very high frequency power conversion," IEEE APEC 2009.

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Topics Covered

- Course Topics
 - High Frequency Power Conversion
 - Switching losses and device selection
 - Resonance in power electronics
 - Soft switching (ZVS and ZCS)
 - Magnetics design
 - Non-resonant soft switching converters
 - Constant frequency control
 - State-plane analysis
 - Resonant switches
 - Modeling and Simulation
 - Discrete time models
 - Resonant Converters
 - Resonant converter topologies
 - Sinusoidal analysis
 - AC-modeling and frequency modulation
 - State-plane analysis
 - Applications and practical issues of high frequency converters

HARD SWITCHING ANALYSIS



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VDMOS



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MOSFET Depletion Capacitance





Gate Charge

9 Typ. gate charge

 V_{GS} =f(Q_{gate}); I_{D} =5.2 A pulsed

parameter: V_{DD}



Pg=VeeQg TENNESSEE KNOXVILLE